

<b>Notice of References Cited</b>	Application/Control No. 10/609,499		Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner Nathan W. Ha		Art Unit 2814	Page 1 of 1

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*	B	US-6,249,045 B1	06-2001	Kresge et al.	257/678
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	M	US-			

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**NON-PATENT DOCUMENTS**

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